



innovations
for high
performance
microelectronics

Modeling a parasitic vertical bipolar transistor

Wipf, Christian

**IHP
Im Technologiepark 25
15236 Frankfurt (Oder)
Germany**



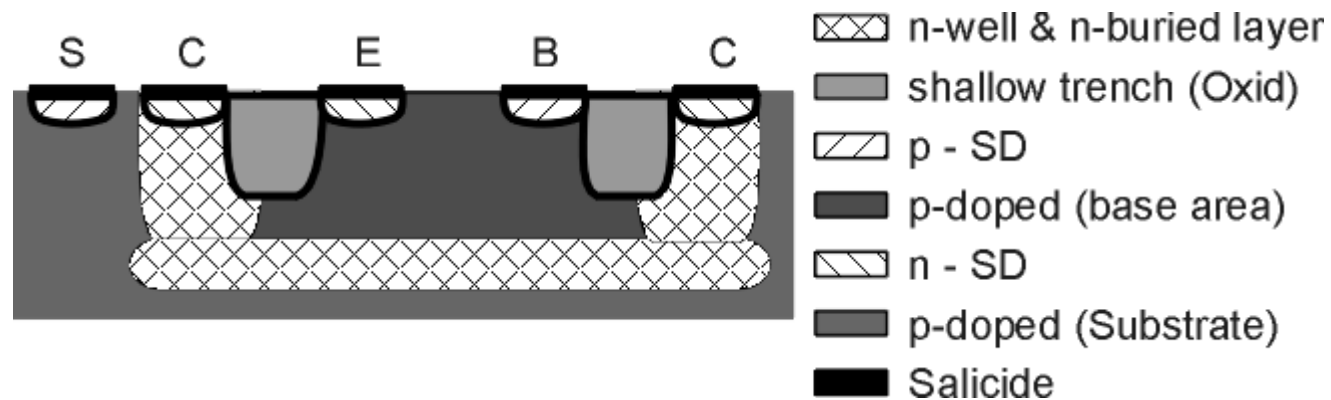
Overview

- **Technology**
- **Structure**
- **Measurement**
- **Plots**



- **SiGe:C – BiCMOS** (SGB25VD – des IHP)
 - SiGe** : Silicium Germanium (not used)
 - C** : Carbon (not used)
 - Bi** : Bipolar (not used)
 - CMOS** : Complementary Metal Oxide Semiconductor

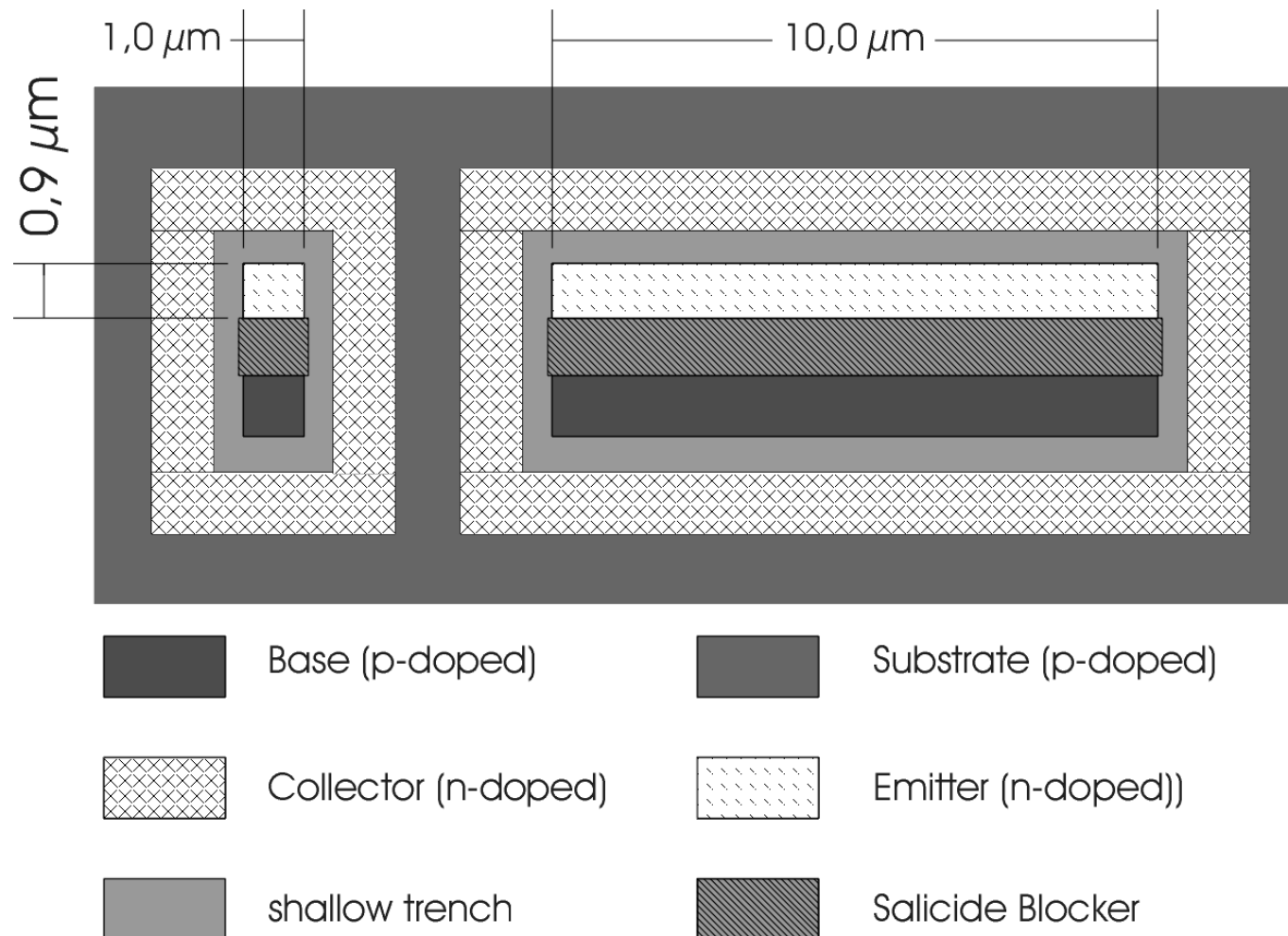
Transistor (side view)



- **Parasitic bipolar transistor of an isolated NMOS – transistor**
- **Bipolar modul is not necessary → cheap (CMOS + LDMOS)**
- **Can be used in bandgap circuits**

Transistor (top view)

1 μm and 10 μm emitterlength

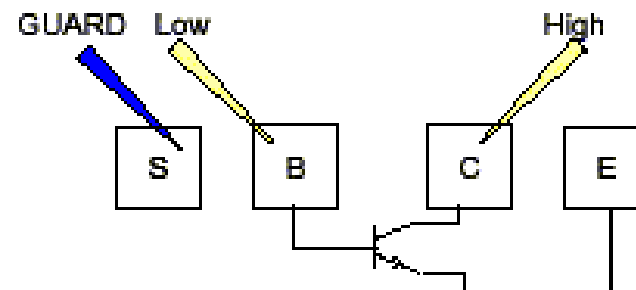
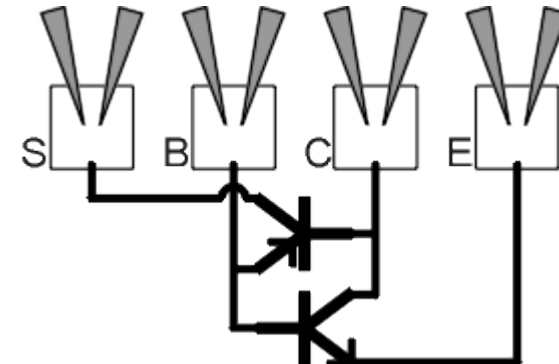




- **IC-CAP was used**
- **DC- Characteristics**
(- 40, -10, 27, 70, 125) °C
(1, 3, 10, 50) μm Emitterlength
- **CV- Characteristics**
(- 40, 27, 125) °C
(1, 3, 10, 50) μm Emitterlength

measurement

- **DC- behaviour**
 - Source Measurement Unit (SMU HP 4142)
 - Triaxialwire
 - Kelvin-Probes
- **Capacitance**
 - LCR-Meter (HP 4284 A)
 - 'Auto Balanced Bridge' (additional guard)





Temperaturedependent parameter (GP – Model)

- **Activation energy** *EG*
- **Built – in potentials** *VJE, VJC, VJS*
- **Zero bias capacitances** *CJE, CJC, CJS*
- **Saturation current** *IS, ISE, ISC*
- **Current gain** *BF, BR*

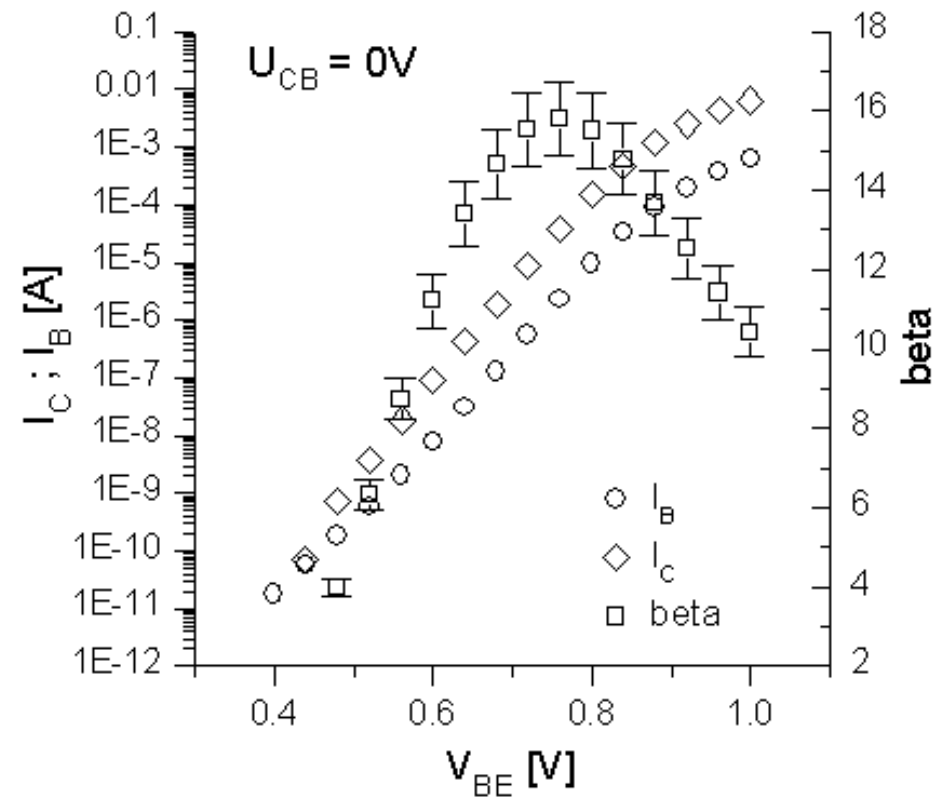


Temperaturedependent parameter (VBIC – Model)

- **Built – in potentials** *PE, PC, PS*
- **Zero bias capacitances** *CJE, CJC, CJCP, CJEP*
- **Saturation currents** *IS, IBEI, IBEN, IBCI, IBCN, etc.*
- **Emission coefficients** *NF, NR*
- **resistors** *RE, RB, RC, RS, RBP*
- **Avalanche parameter** *AVC2*
- **Self – heating**

Forward Gummel

Temperature: 27 °C ; emitterlength: 10 μm

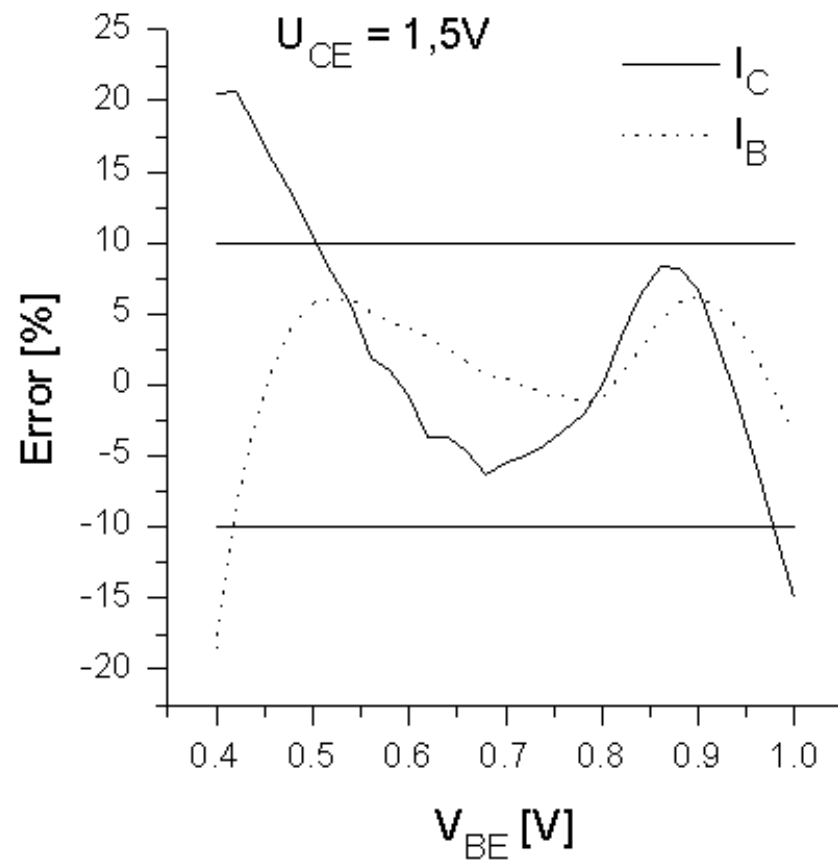


Simulation error

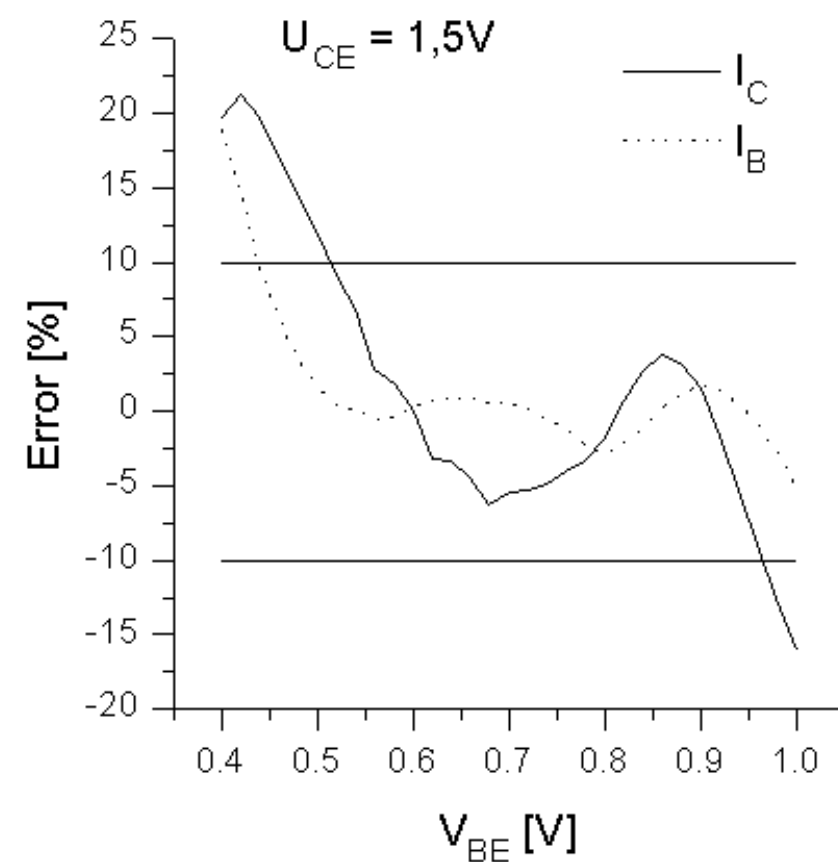
Temperature: 27 °C ; emitterlength: 10 μm

Error = 100 % · (Simulation – Measurement) / Measurement

GP – model

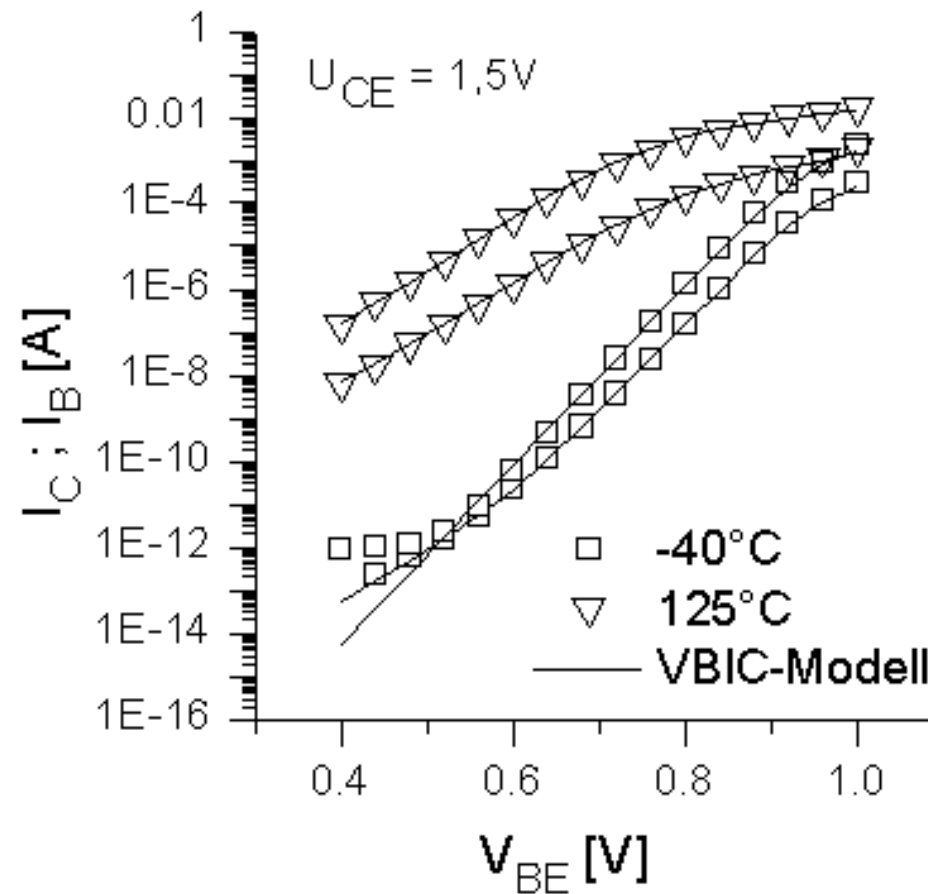


VBIC – model



Forward Gummel (Temperature)

Temperature: - 40 °C, 125 °C ; emitterlength: 10 μm

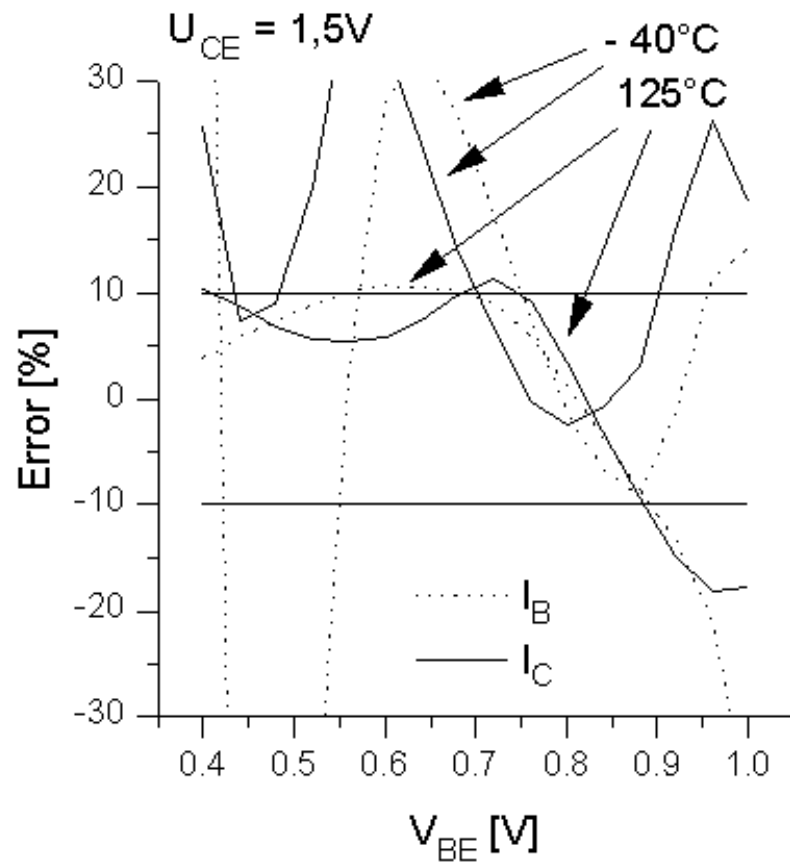


Forward Gummel

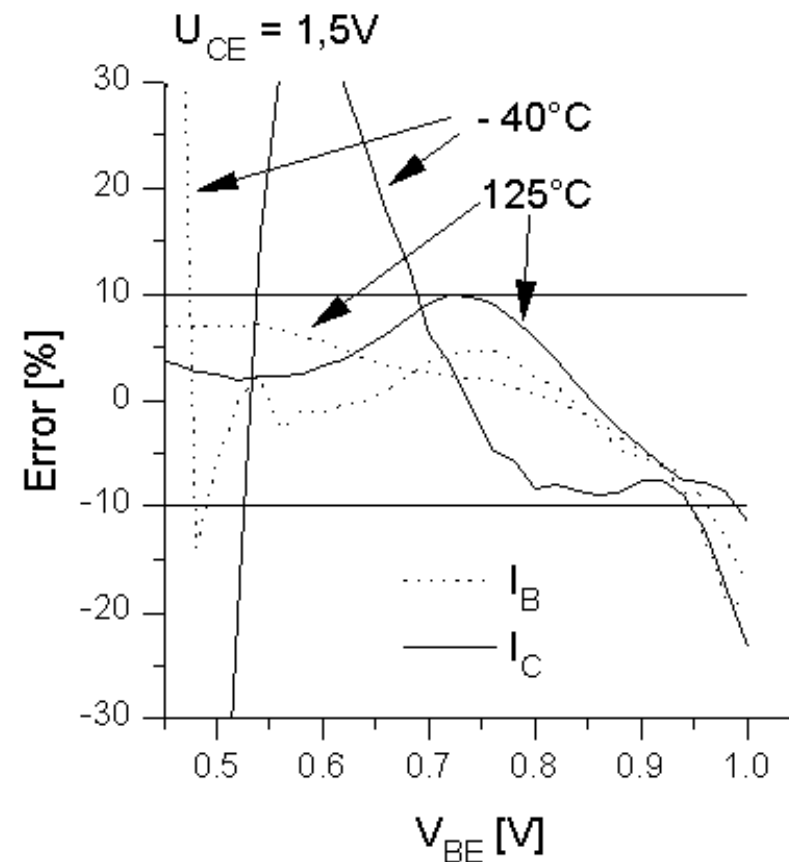
Temperature: - 40 °C, 125°C ; emitterlength: 10 μm

Error = 100 % · (Simulation – Measurement) / Measurement

GP – model



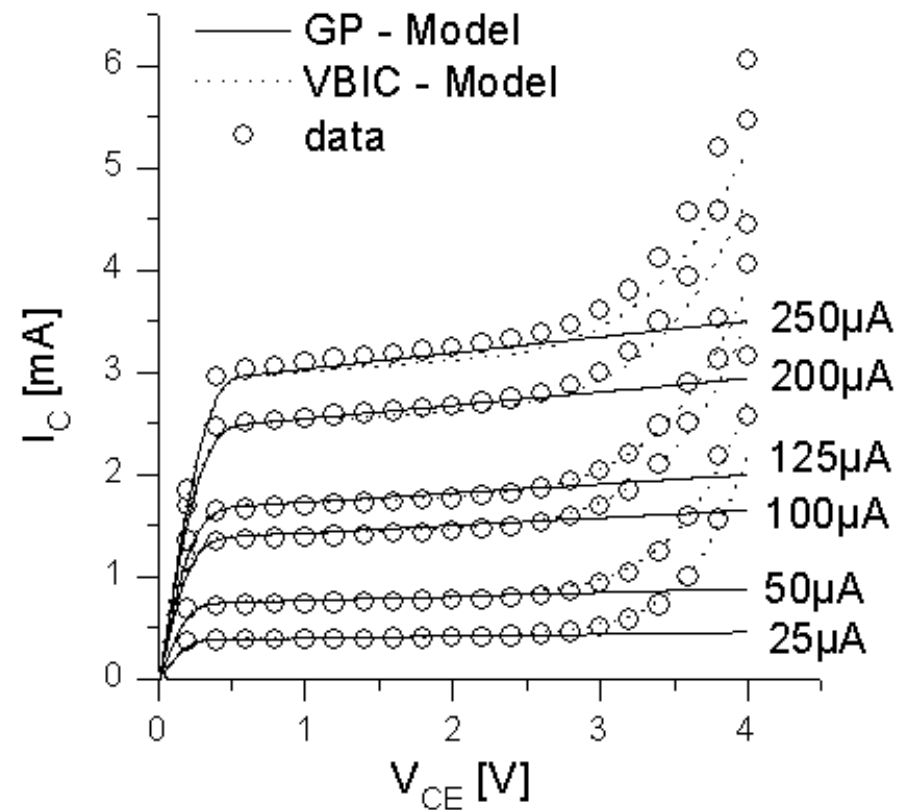
VBIC – model



Forward Output

Temperature: 27 °C ; emitterlength: 10 μm

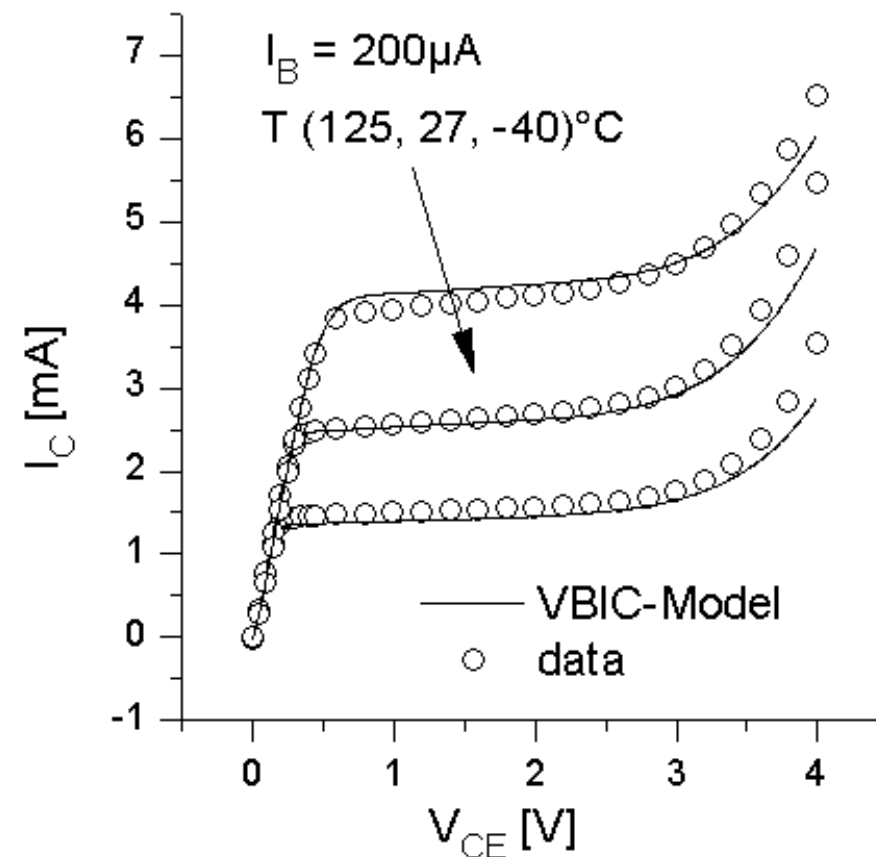
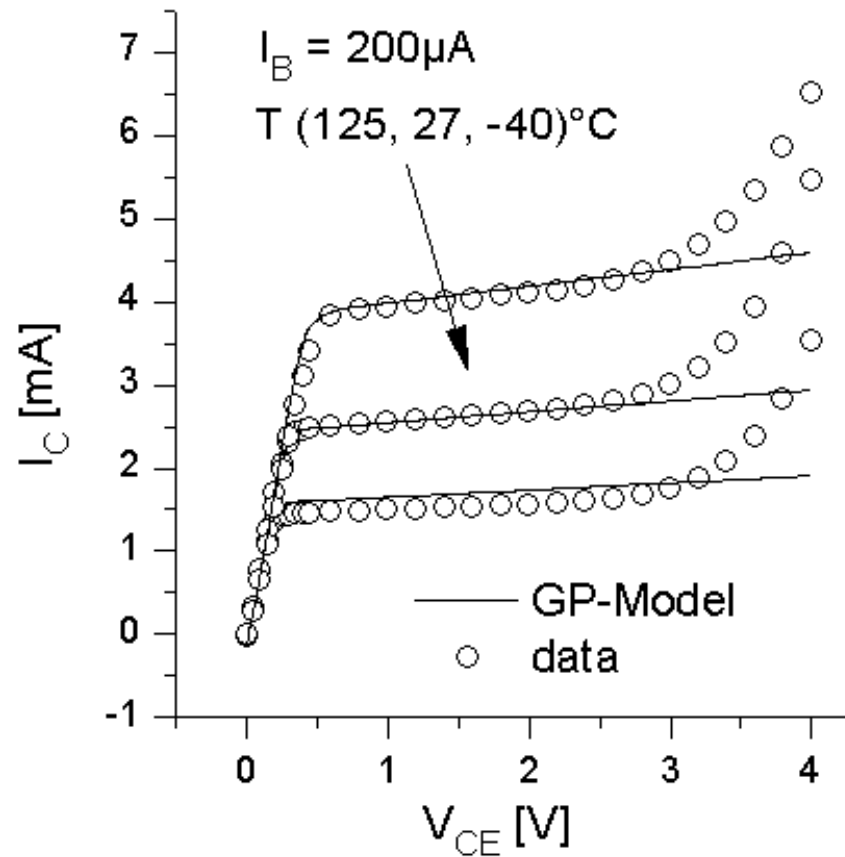
I_B : (25, 50, 100, 125, 200, 250) μA



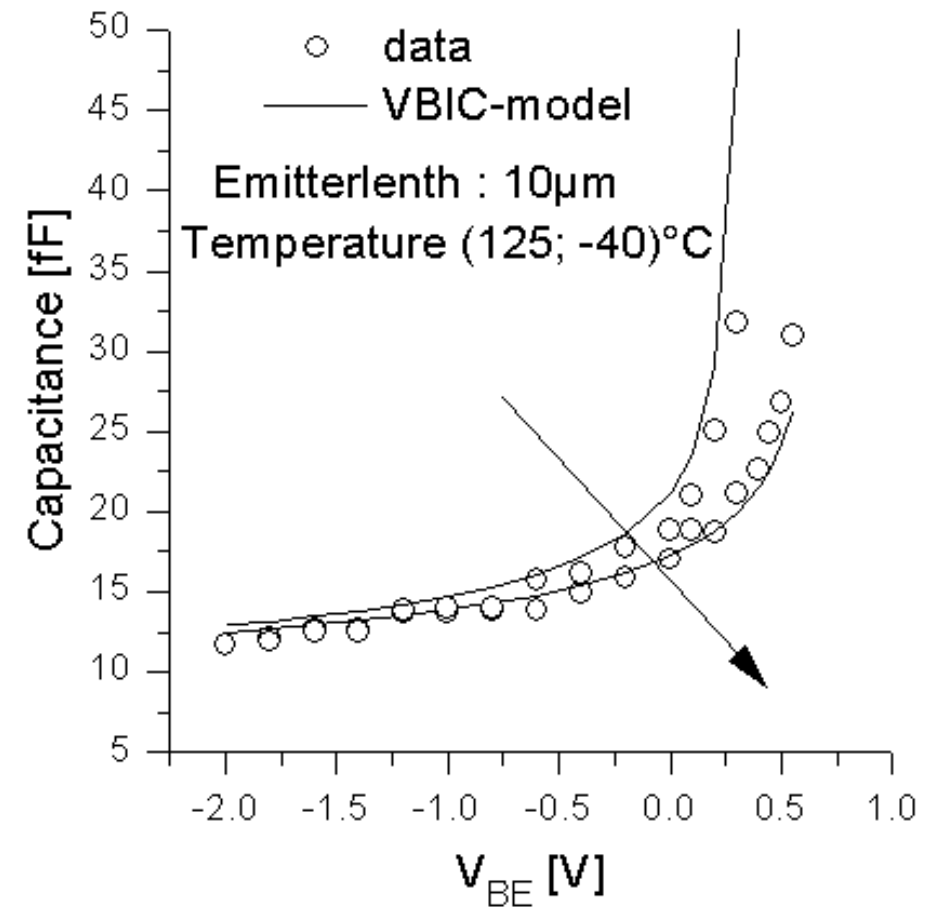
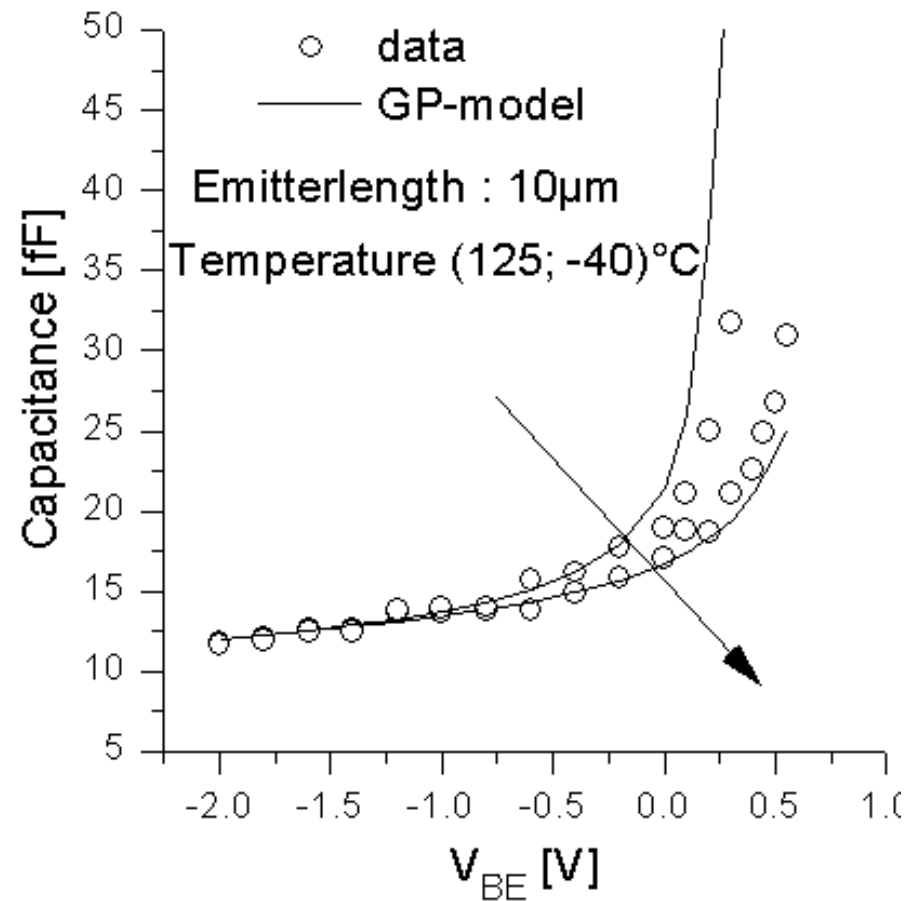
Forward Output

Temperature: (- 40, 27, 125) °C ; emitterlength: 10 μm

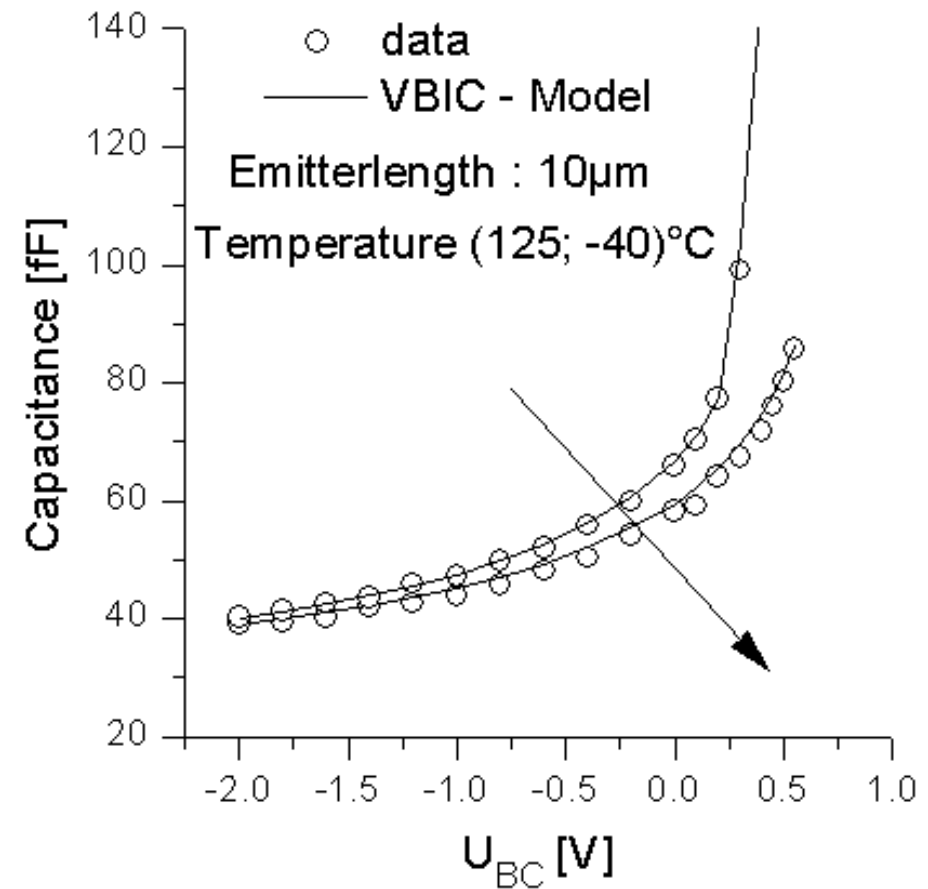
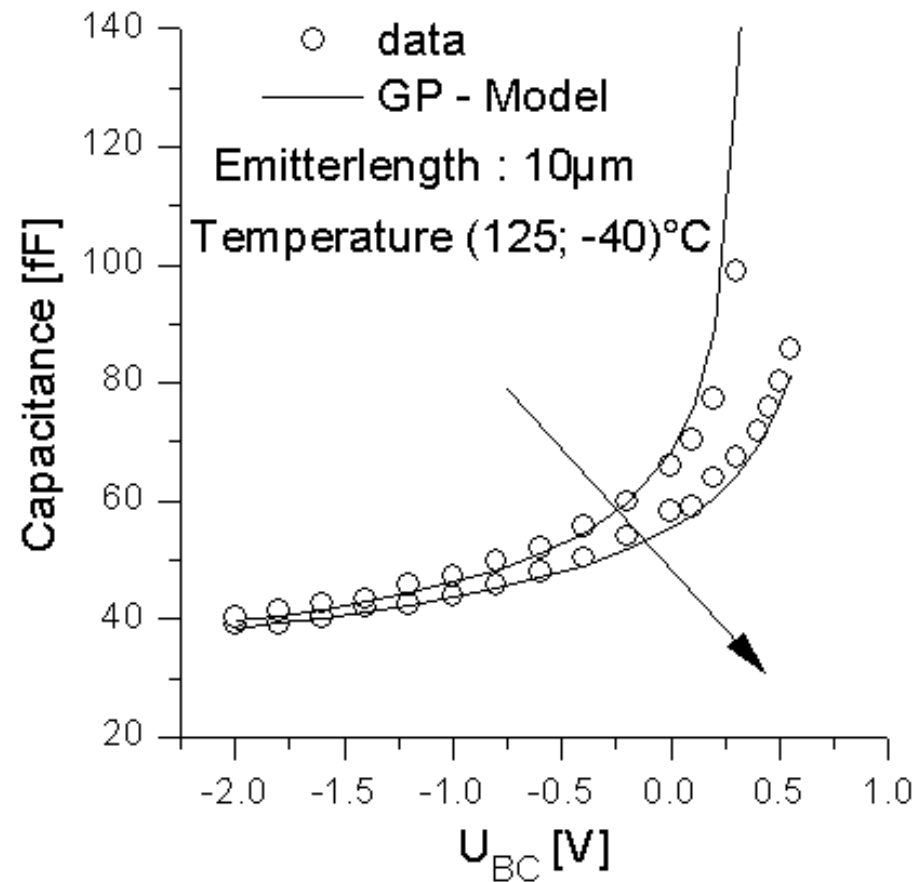
$I_B : 200 \mu A$



Base – Emitter – Capacitance



Base – Collector – Capacitance





Thank you for your attention